Search Notes

Application/Control N	lo. Applicant(s)/Patent under Reexamination
10/519,006	SPECHT ET AL.
Examiner .	Art Unit
Lois Zheng	1793

SEARCHED					
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventorship search	11/13/2007	LLZ	
EAST Search	11/13/2007	LLZ	